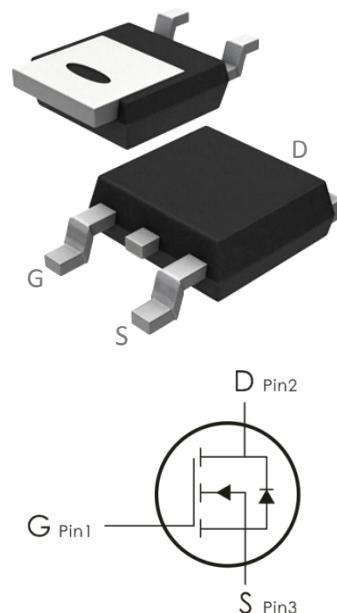


Description:

This N-Channel MOSFET uses advanced trench technology and design to provide excellent $R_{DS(on)}$ with low gate charge. It can be used in a wide variety of applications.

Features:

- 1) $V_{DS}=60V, I_D=55A, R_{DS(on)}<12m\Omega @ V_{GS}=10V$
- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density trench technology for ultra low $R_{DS(on)}$.
- 5) Excellent package for good heat dissipation.



Absolute Maximum Ratings: ($T_c=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
V_{DS}	Drain-Source Voltage	60	V
V_{GS}	Gate-Source Voltage	± 25	V
I_D	Continuous Drain Current $T_c=25^\circ C$	55	A
	Continuous Drain Current $T_c=100^\circ C$	36	
E_{AS}	Single Pulse Avalanche Energy ^{note2}	59	mJ
I_{DM}	Pulsed Drain Current ^{note1}	220	A
P_D	Power Dissipation $T_c=25^\circ C$	63	W
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +175	$^\circ C$

Thermal Characteristics:

Symbol	Parameter	Max	Units
R_{eJC}	Thermal Resistance,Junction to Case	2.4	$^\circ C/W$

Package Marking and Ordering Information:

Part No.	Marking	Package
DOD55N06-H	55N06-H	TO-252

Electrical Characteristics: ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250 \mu\text{A}$	60	---	---	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=60\text{V}$	---	---	1	μA
I_{GSS}	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 25\text{V}, V_{\text{DS}}=0\text{V}$	---	---	± 100	nA
On Characteristics						
$V_{\text{GS}(\text{th})}$	GATE-Source Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}, I_{\text{D}}=250 \mu\text{A}$	2	3	4	V
$R_{\text{DS}(\text{ON})}$	Drain-Source On Resistance ^{note3}	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=30\text{A}$	---	8	12	$\text{m}\Omega$
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{\text{DS}}=25\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	---	2045	---	pF
C_{oss}	Output Capacitance		---	170	---	
C_{rss}	Reverse Transfer Capacitance		---	151	---	
Switching Characteristics						
$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{GS}}=10\text{V}, V_{\text{DS}}=30\text{V}, R_{\text{L}}=1.5\Omega, R_{\text{GEN}}=3\Omega$	---	10	---	ns
t_r	Rise Time		---	8	---	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		---	18	---	ns
t_f	Fall Time		---	5	---	ns
Q_g	Total Gate Charge	$V_{\text{GS}}=10\text{V}, V_{\text{DS}}=30\text{V}, I_{\text{D}}=20\text{A}$	---	16	---	nC
Q_{gs}	Gate-Source Charge		---	5.6	---	nC
Q_{gd}	Gate-Drain "Miller" Charge		---	3.6	---	nC
Drain-Source Diode Characteristics						
I_s	Maximum Continuous Drain to Source Diode Forward Current	---	---	55	A	
I_{SM}	Maximum Pulsed Drain to Source Diode Forward Current	---	---	220	A	
V_{SD}	Source-Drain Diode Forward Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=30\text{A}$	---	---	1.2	V
trr	Body Diode Reverse Recovery Time	$I_F=20\text{A}, dI/dt=50\text{A}/\mu\text{s}$	---	18	---	ns

Qrr	Body Diode Reverse Recovery Charge	I _F =20A, dI/t=50A/ μ s	---	58	---	nc
------------	------------------------------------	------------------------------------	-----	----	-----	----

Notes:

1. Reptive Rating: Pulse Width Limited by Maximum Junction Temperature

2. EAS conditon : TJ=25°C, VD=30V, G=10V, L=0.5mH, Rg=25 Ω, IAS=15.3A

3. Pulse Tst: Pulse Width≤30 μ s, Duty Cycle≤0.5%

Typical Characteristics: (T_A=25°C unless otherwise noted)

Figure 1: Output Characteristics

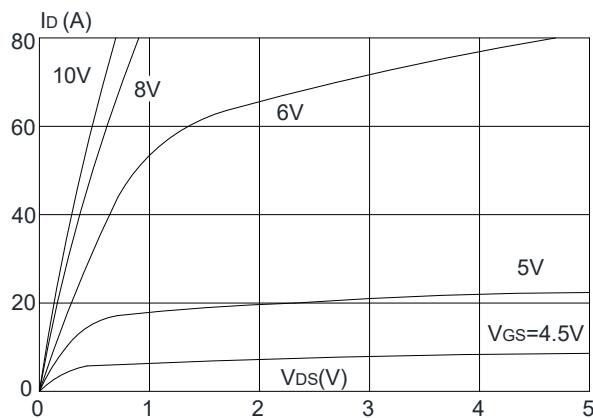


Figure 2: Typical Transfer Characteristics

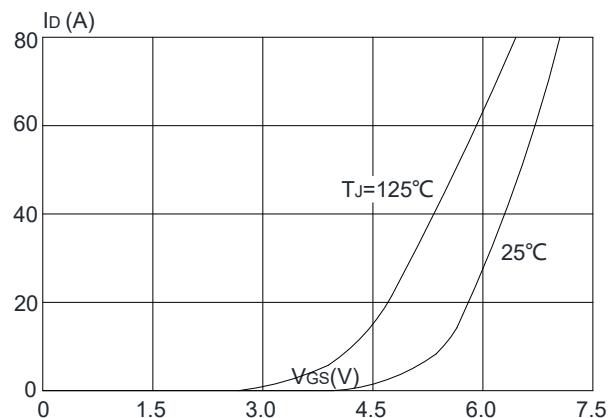


Figure 3: On-resistance vs. Drain Current

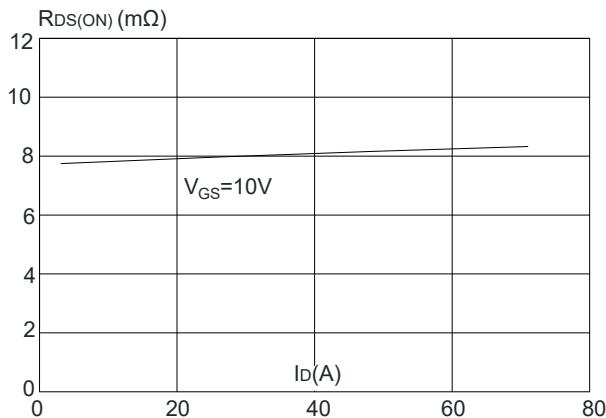


Figure 5: Gate Charge Characteristics

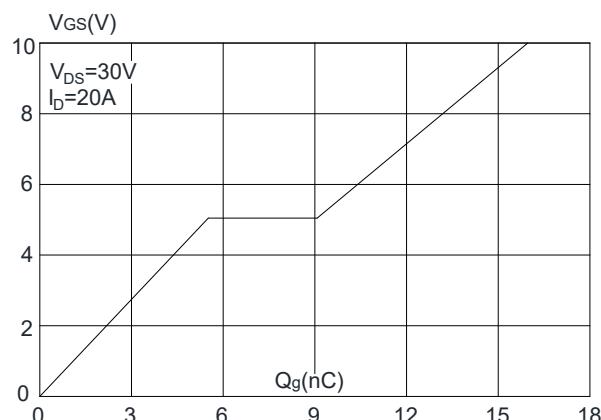


Figure 4: Body Diode Characteristics

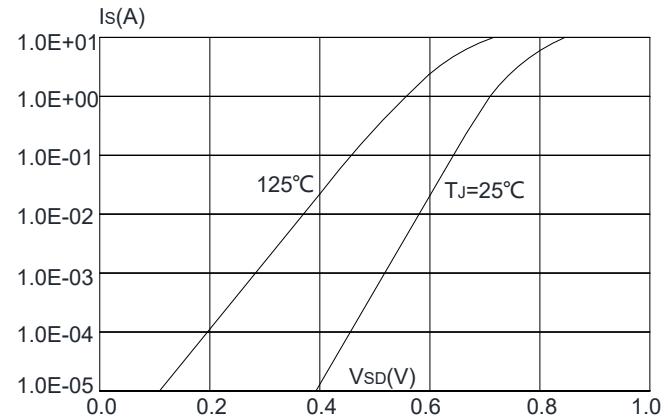


Figure 6: Capacitance Characteristics

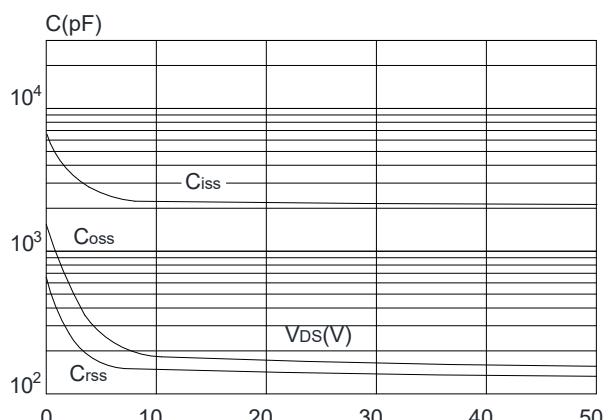


Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

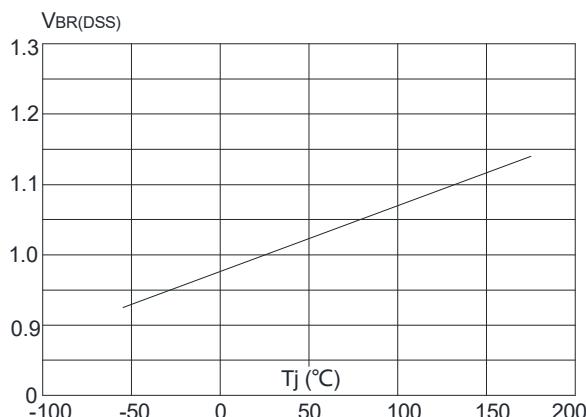


Figure 8: Normalized on Resistance vs. Junction Temperature

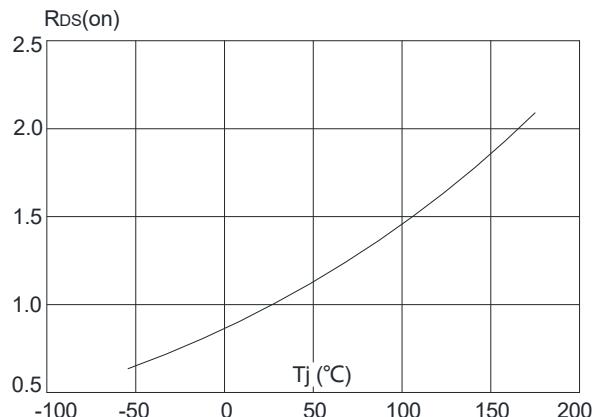


Figure 9: Maximum Safe Operating Area

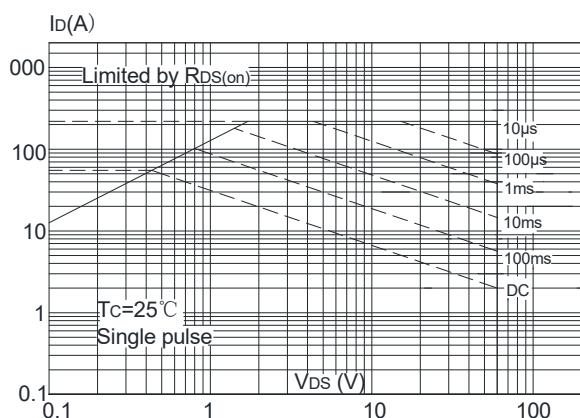


Figure 10: Maximum Continuous Drain Current vs. Case Temperature

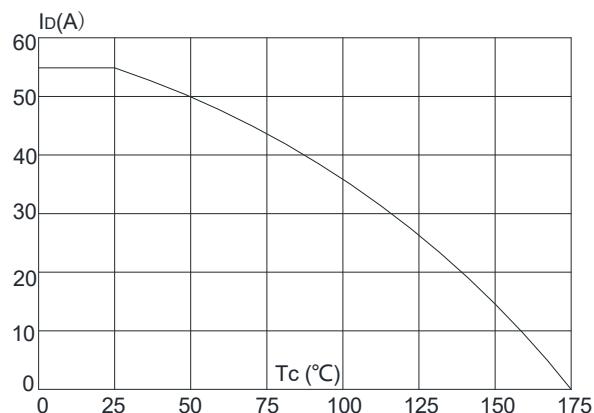


Figure 11: Maximum Effective Transient Thermal Impedance, Junction-to-Case

